

Search Notes

Application/Control No.

10/530,837

Examiner

QUANG NGUYEN, Ph.D.

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1633

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
536	23.5	1/6/2010	QN
435	69.1	1/6/2010	QN
435	455	1/6/2010	QN
US-PreGrant Publication Full-Text Database		1/6/2010	QN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated previous searches (see attached)	1/6/2010	QN
Updated inventor's name search	1/6/2010	QN
Interference searches for SEQ ID NOs. 1 and 3	4/7/2009	STIC